

N-Channel MOSFET

Applications:

- Adaptor
- Charger
- •SMPS

Features:

- RoHS Compliant
- . Low ON Resistance
- •Low Gate Charge
- •Peak Current vs Pulse Width Curve
- Inductive Switching Curves

Ordering Information

PART NUMBER	PACKAGE	BRAND
ITL07N80A	TO-262	IPS

Absolute Maximum Ratings T_C=25℃ u

 T_C =25°C unless otherwise specified

S

Pb

Symbol	Parameter	ITL07N80A	Units
V _{DSS}	Drain-to-Source Voltage	800	V
ID	Continuous Drain Current	7	А
I _{DM}	Pulsed Drain Current, V _{GS} @10V (NOTE *2)	28	Α
D	Power Dissipation	150	W
P _D	Derating Factor above 25℃	1.2	W/℃
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy (L=10mH)	130	mJ
TL	Maximum Temperature for Soldering	300	
$T_{\rm J}$ and $T_{\rm STG}$	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	°C

Thermal Resistance

Symbol	Parameter	Тур.	Units	Test Conditions
Б	Junction-to-Case	0.83		Water cooled heatsink, P_{D} adjusted for a
$R_{ extsf{ heta}JC}$	Junction-to-Case	0.05	°C /W	peak junction temperature of +150 $^\circ\!\!{ m C}$.
R _{0JA}	Junction-to-Ambient	62		1 cubic foot chamber, free air.

) Lead Free Package and Finish

G

V _{DSS}	R _{DS(ON)} (Typ.)	I _D
800V	1.5Ω	7A

TO-262

Package Not to Scale

ITL07N80A

D

s



OFF Characteristics $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	800			V	V _{GS} =0V, I _D =250µA
I _{DSS}	Drain-to-Source Leakage Current			10	μA	V _{DS} =800V, V _{GS} =0V
						T J=25 ℃
				100		V_{DS} =640V, V_{GS} =0V
						T 」=125 ℃
I _{GSS}	Gate-to-Source Forward Leakage			+100	20	V_{GS} =+30V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -30V

ON Characteristics $T_J=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
R _{DS(ON)}	StaticDrain-to-Source On-Resistance		1.5	1.6	Ω	V _{GS} =10V, I _D =3.5A
V _{GS(TH)}	Gate Threshold Voltage	2		4	V	V _{DS} =V _{GS} ,I _D =250µA
g _{fs}	Forward Transconductance		5.5		S	V _{DS} =30V, I _D =7A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C _{iss}	Input Capacitance		1350	-		(1 - 0)(1) - 25(1)
C _{oss}	Output Capacitance		120		рF	V _{GS} = 0V,V _{DS} = 25V f =1.0MHz
C _{rss}	Reverse Transfer Capacitance		12			
Qg	Total Gate Charge		34			
Q _{gs}	Gate-to-Source Charge		6	-	nC	I _D =7A,V _{DD} =400V V _{GS} = 10V
Q _{gd}	Gate-to-Drain ("Miller") Charge		14			

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
t _{d(ON)}	Turn-on Delay Time		15		ns	V _{DD} =400V, I _D =7A, V _G =10V R _G =12Ω
t _{rise}	Rise Time		25			
t _{d(OFF)}	Turn-Off Delay Time		50			
t _{fall}	Fall Time		30			

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Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)			7	А	T -25°0
I _{SM}	Maximum Pulsed Current (Body Diode)			28	А	− T _C =25°C
V_{SD}	Diode Forward Voltage			1.5	V	I _{SD} =7A, V _{GS} =0V
t _{rr}	Reverse Recovery Time		185		ns	I _F = 7A
Q _{rr}	Reverse Recovery Charge		850		nC	di/dt=100A/us

Source-Drain Diode Characteristics Tc=25°C unless otherwise specified

Notes:

*1. T_J = +25℃ to +150℃.

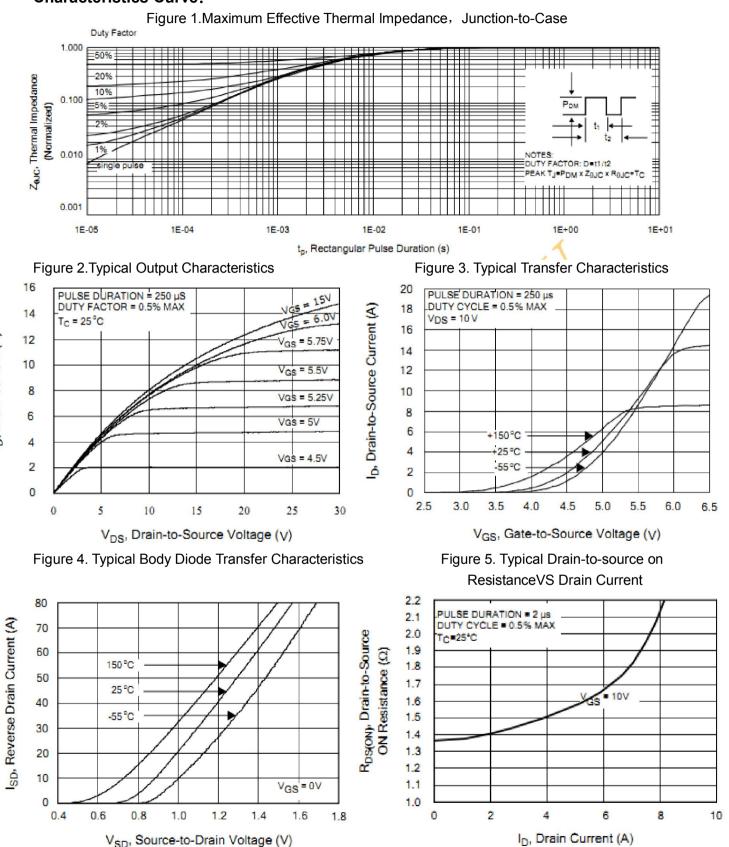
*2. Repetitive rating; pulse width limited by maximum junction temperature.

*3. Pulse width < 380 μ s; duty cycle < 2%.

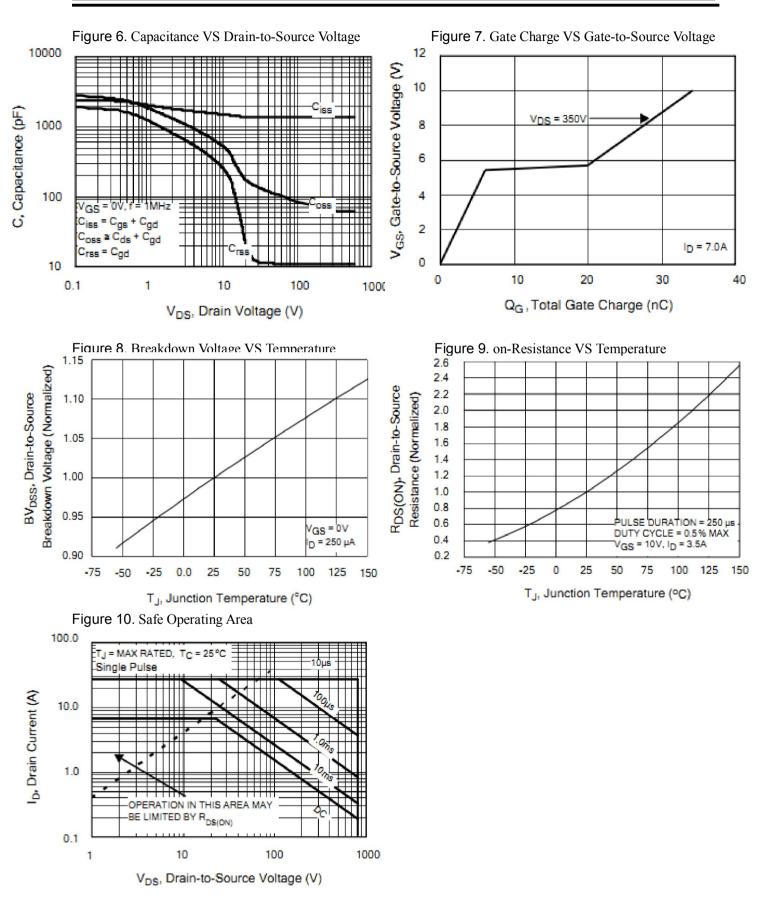


I_D, Drain Current (A)

Characteristics Curve:



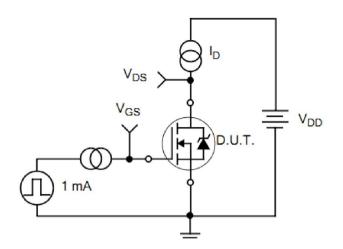






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Test Circuits and Waveforms



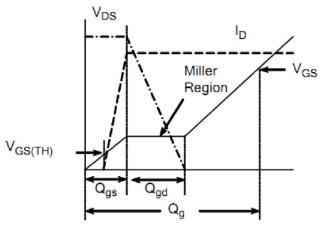


Figure 11. Gate Charge Test Circuit

Figure 12. Gate Charge Waveforms

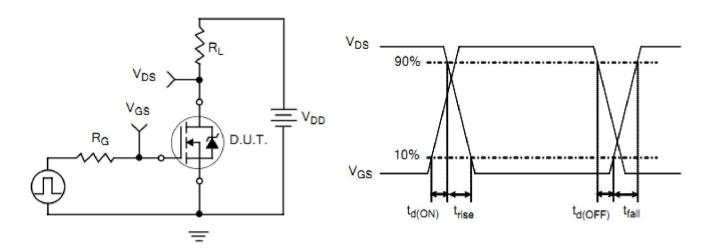
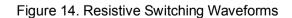
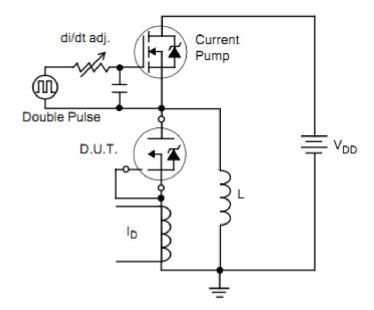


Figure 13. Resistive Switching Test Circuit







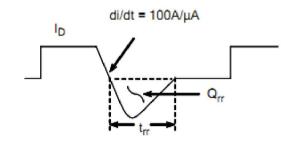


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

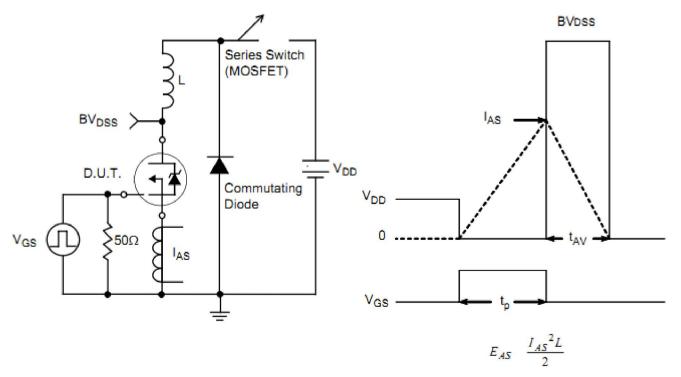


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



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